

Type	Hits	Search Text	Dbs	Time Stamp	Cor m De fin s	Err or s
1 BRS	66	(circumscrib\$3 near\$3 (arc\$1 circle\$1curve\$1)) and image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:42		0
2 BRS	12	("4783829" "4972495" "5073958" "5091967" "5115477" "5119439" "5119440" "5181261" "5301264" "5369714" "5369742" "5719951"),PN.	USPAT	2004/03/26 11:17		0
3 BRS	2	5887081.URPN.	USPAT	2004/03/26 11:22		0
4 BRS	17	("4620287" "4674058" "4779224" "4928233" "4943935" "5065348" "5179644" "5214754" "5233671" "5237649" "5241654" "5261029" "5269000" "5282143" "5287441" "5309521" "5345546"),PN.	USPAT	2004/03/26 11:25		0
5 BRS	9	5594852.URPN.	USPAT	2004/03/26 11:37		0
6 BRS	221	(enclos\$3 near\$3 (arc\$1 circle\$1curve\$1)) and image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:53		0
7 BRS	55	(enclos\$3 near\$3 (arc\$1 circle\$1curve\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 15:56		0
8 BRS	5674	345/441-442;382/141-152,199,203,286.cds.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:54		0
9 BRS	500	345/441-442;382/141-152,199,203,286.cds. and (detect\$1 with area\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:55		0
10 BRS	207	345/441-442;382/141-152,199,203,286.cds. and ((detect\$3 near\$3 defect\$1) with area\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:56		0
11 BRS	85	(345/441-442;382/141-152,199,203,286.cds. and ((detect\$3 near\$3 defect\$1) with area\$1)) and overlap\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 11:56		0
12 BRS	5152	(inspect\$3 defect\$1) same (gear\$1 sprocket\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 14:29		0
13 BRS	163	((inspect\$3 defect\$1) with (gear\$1 sprocket\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:00		0

Type	Hits	Search Text	Dbs	Time Stamp	Cor m n s	Er m n s	Er m n s
14 BRS	33	((inspect\$3 defect\$1) with (sprocket\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 14:38		0	
15 BRS	132	((inspect\$3 defect\$1) with (gear\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/26 14:38		0	
16 BRS	2423	250/559.39,559.45-559.48;348/92,128,135;356/241.5,241.6,628,629;70 2/40,156.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 13:45		0	
17 BRS	116	250/559.39,559.45-559.48;348/92,128,135;356/241.5,241.6,628,629;70 2/40,156.ccls. and ((gear\$3 sprocket\$1 cog\$1) and (image\$3 vision optical))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 13:46		0	
18 BRS	60	(250/559.39,559.45-559.48;348/92,128,135;356/241.5,241.6,628,629;70 2/40,156.ccls. and ((gear\$3 sprocket\$1 cog\$1) and (image\$3 vision optical))) and (defect\$1 flaw\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 13:47		0	
19 BRS	329	((flaw\$1 defect\$1) near\$3 defect\$3 identifi\$7) with (gear\$1 sprocket\$1 cog\$1 ((repetitive repeat\$2) near\$3 (pattern\$1 shape\$1 area\$1 region\$1))) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:12		0	
20 BRS	23	((flaw\$1 defect\$1) adj1 (defect\$3 identifi\$7)) with (gear\$1 sprocket\$1 cog\$1 ((repetitive repeat\$2) near\$3 (pattern\$1 shape\$1 area\$1 region\$1))) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:30		0	
21 IS&R	2	("6510239").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:39		0	
22 BRS	143024	(gear\$1.ti. sprocket\$1.ti. cog\$1.ti.). and (inspect\$4.ti. detect\$3.ti.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:49		0	
23 BRS	2725	(gear\$1.ti. sprocket\$1.ti. cog\$1.ti.) and (inspect\$4.ti. detect\$3.ti.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:51		0	
24 BRS	291	(gear\$1.ti. sprocket\$1.ti. cog\$1.ti.) and (inspect\$4.ti.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:51		0	
25 BRS	288	(gear\$1.ti. sprocket\$1.ti.) and (inspect\$4.ti.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:51		0	

Type	Hits	Search Text	Dbs	Time Stamp	Er or Me ss a g e s	Co r re c t i o n s
26 BRS	261	(gear\$1.ti.) and (inspect\$4.ti.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:52	0	
27 BRS	45	((gear\$1.ti. sprocket\$1.ti. cog\$1.ti.) and (inspect\$4.ti.)) and (imag\$3 optical vision)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 14:52	0	
28 BRS	14	(circumscrib\$3 near3 (arc\$1 circle\$1 curve\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 15:56	0	
29 BRS	4	((circumscrib\$3 enclos\$3) near3 (chord\$1)) same image\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/29 15:57	0	
30 BRS	77	(imaging adj1 system) with (band\$1 pass adj1 filter)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/30 09:56	0	
31 BRS	1	(imaging adj1 system) with (band\$1 pass adj1 filter) same inspect\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/30 09:57	0	
32 BRS	22	(imaging adj1 system) with (band\$1 pass adj1 filter) and inspect\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/30 09:57	0	
33 BRS	211	((classif\$7 partition\$3 group\$3 cluster\$3) with ((repetitive repeat\$3) near3 (pattern\$1 object\$1 character\$1 area\$1)))) same imag\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/03/30 11:37	0	

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

Membership | Publications/Services | Standards | Conferences | Careers/Jobs

IEEE Xplore®

IEEE 10

Welcome
United States Patent and Trademark Office



Help | FAQ | Terms | IEEE Peer Review

Quick Links



» Search Results

Welcome to IEEE Xplore®

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conferences Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

Your search matched **2** of **1015452** documents.

A maximum of **500** results are displayed, **15** to a page, sorted by **Relevance** in **Descending** order.

Refine This Search:

You may refine your search by editing the current search expression or entering a new one in the text box.

Inspection<and>circumscribing

Search

☐ Check to search within this result set

Results Key:

JNL = Journal or Magazine CNF = Conference STD = Standard

1 Non-destructive defect detection scheme using Kerr-channel optical surface analyzer

Tsai, J.W.H.; Nathanson, M.; Kimball, R.; Geiss, R.; Logan, T.; Nguyen, T.; Magnetics, IEEE Transactions on , Volume: 37 , Issue: 4 , July 2001
Pages:1957 - 1959

[Abstract] [PDF Full-Text (216 KB)] IEEE JNL

2 Shape estimation in computer tomography from minimal data

Stark, H.; Hui Peng; Pattern Recognition, 1988., 9th International Conference on , 14-17 Nov. 1988
Pages:184 - 186 vol.1

[Abstract] [PDF Full-Text (196 KB)] IEEE CNF